


<b>Search Notes</b> 	<b>Application/Control No.</b> 10033027	<b>Applicant(s)/Patent Under Reexamination</b> SNYDER, WARREN
	<b>Examiner</b> IDRIS N ALROBAYE	<b>Art Unit</b> 2183

### SEARCHED

Class	Subclass	Date	Examiner
712	15, 17, 18, 36, 35, 37, 38	4/15/2005	DP
716	13, 14, 17	4/15/2005	DP
712	15, 35, 36	10/25/2005	DP
712	15, 35, 36	12/15/2006	DP
712	15, 35, 36, 32	3/24/2009	IA
716	14, 17	3/24/2009	IA

### SEARCH NOTES

Search Notes	Date	Examiner
uspat, pgp full text, jopabs, epoabs, derwent, ibm tdb, ieee npl	4/15/2005	DP
west pgp uspat epoabs jpoabs derwent IBM TD IEEE NPL, 712/17,18,37,38; 716/13,14,17	10/25/2005	DP
west pgp uspat epoabs jpoabs derwent IBM TD IEEE NPL, 712/17,18,37,38; 716/13,14,17	12/15/2006	DP
Inventor search for double patenting (PALM)	3/18/2009	IA
see east search history	3/18/2009	IA
NPL(google scholar, terms used: configurable or reconfigurable microcontroller including analog and digital logic or circuits)	3/23/2009	IA

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
712	15, 32, 35, 36 PG-Pub and text search	3/24/2009	IA
716	17, 14 PG-Pub and text search	3/24/2009	IA

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